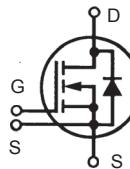


HiPerFET™ Power MOSFETs Single Die MOSFET

N-Channel Enhancement Mode
Avalanche Rated, High dv/dt, Low t_{rr}

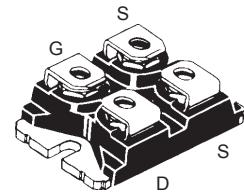
IXFN 340N07



V_{DSS} = 70 V
 I_{D25} = 340 A
 $R_{DS(on)}$ = 4 mΩ

$t_{rr} \leq 200\mu s$

miniBLOC, SOT-227 B (IXFN)
 E153432



G = Gate D = Drain
S = Source

Either Source terminal at miniBLOC can be used as Main or Kelvin Source

Symbol	Test Conditions	Maximum Ratings		
V_{DSS}	$T_J = 25^\circ C$ to $150^\circ C$	70		V
V_{DGR}	$T_J = 25^\circ C$ to $150^\circ C$; $R_{GS} = 1 M\Omega$	70		V
V_{GS}	Continuous	± 20		V
V_{GSM}	Transient	± 30		V
I_{D25}	$T_c = 25^\circ C$, Chip capability	340		A
$I_{L(RMS)}$	Terminal current limit	100		A
I_{DM}	$T_c = 25^\circ C$, pulse width limited by T_{JM}	1360		A
I_{AR}	$T_c = 25^\circ C$	200		A
E_{AR}	$T_c = 25^\circ C$	64		mJ
E_{AS}	$T_c = 25^\circ C$	4		J
dv/dt	$I_s \leq I_{DM}$, $di/dt \leq 100 A/\mu s$, $V_{DD} \leq V_{DSS}$, $T_J \leq 150^\circ C$, $R_G = 2 \Omega$	10		V/ns
P_D	$T_c = 25^\circ C$	700		W
T_J		-55 ... +150		$^\circ C$
T_{JM}		150		$^\circ C$
T_{stg}		-55 ... +150		$^\circ C$
V_{ISOL}	50/60 Hz, RMS $t = 1$ min $I_{ISOL} \leq 1$ mA $t = 1$ s	2500 3000	V~	
M_d	Mounting torque Terminal connection torque	1.5/13	Nm/lb.in. 1.5/13	Nm/lb.in.
Weight		30		g

Symbol	Test Conditions	Characteristic Values		
		($T_J = 25^\circ C$, unless otherwise specified)	min.	typ.
V_{DSS}	$V_{GS} = 0$ V, $I_D = 3$ mA	70		V
$V_{GH(th)}$	$V_{DS} = V_{GS}$, $I_D = 8$ mA	2.0		4.0 V
I_{GSS}	$V_{GS} = \pm 20$ V _{DC} , $V_{DS} = 0$			± 200 nA
I_{DSS}	$V_{DS} = V_{DSS}$ $V_{GS} = 0$ V	$T_J = 25^\circ C$ $T_J = 125^\circ C$	100 2	μA mA
$R_{DS(on)}$	$V_{GS} = 10$ V, $I_D = 100$ A Pulse test, $t \leq 300$ μs , duty cycle $d \leq 2$ %			4 mΩ

Features

- International standard package
- miniBLOC, with Aluminium nitride isolation
- Low $R_{DS(on)}$ HDMOS™ process
- Rugged polysilicon gate cell structure
- Unclamped Inductive Switching (UIS) rated
- Low package inductance
- Fast intrinsic Rectifier

Applications

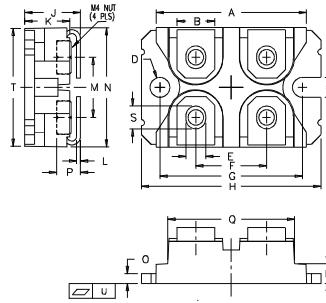
- DC-DC converters
- Battery chargers
- Switched-mode and resonant-mode power supplies
- DC choppers
- Temperature and lighting controls
- Linear current regulators

Advantages

- Easy to mount
- Space savings
- High power density

Symbol	Test Conditions	Characteristic Values			
		($T_J = 25^\circ\text{C}$, unless otherwise specified)	min.	typ.	max.
g_{fs}	$V_{DS} = 10 \text{ V}; I_D = 60 \text{ A}$, pulse test	80	98	S	
C_{iss} C_{oss} C_{rss}	$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	12200		pF	
		7100		pF	
		3340		pF	
$t_{d(on)}$ t_r $t_{d(off)}$ t_f	$V_{GS} = 10 \text{ V}, V_{DS} = 0.5 \cdot V_{DSS}, I_D = 100 \text{ A}$ $R_G = 1 \Omega$ (External)	100		ns	
		95		ns	
		200		ns	
		33		ns	
$Q_{g(on)}$ Q_{gs} Q_{gd}	$V_{GS} = 10 \text{ V}, V_{DS} = 50 \text{ V}, I_D = 100 \text{ A}$	490		nC	
		72		nC	
		266		nC	
R_{thJC}			0.18	K/W	
R_{thCK}			0.05	K/W	

miniBLOC, SOT-227 B



Dim.	Millimeter Min.	Millimeter Max.	Inches Min.	Inches Max.
A	31.50	31.88	1.240	1.255
B	7.80	8.20	0.307	0.323
C	4.09	4.29	0.161	0.169
D	4.09	4.29	0.161	0.169
E	4.09	4.29	0.161	0.169
F	14.91	15.11	0.587	0.595
G	30.12	30.30	1.186	1.193
H	38.00	38.23	1.496	1.505
J	11.68	12.22	0.460	0.481
K	8.92	9.60	0.351	0.378
L	0.76	0.84	0.030	0.033
M	12.60	12.85	0.496	0.506
N	25.15	25.42	0.990	1.001
O	1.98	2.13	0.078	0.084
P	4.95	5.97	0.195	0.235
Q	26.54	26.90	1.045	1.059
R	3.94	4.42	0.155	0.174
S	4.72	4.85	0.186	0.191
T	24.59	25.07	0.968	0.987
U	-0.05	0.1	-0.002	0.004

Source-Drain Diode

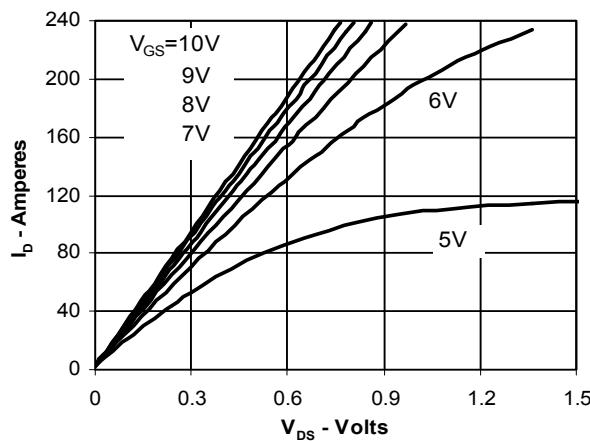
Characteristic Values
($T_J = 25^\circ\text{C}$, unless otherwise specified)

Symbol	Test Conditions	min.	typ.	max.
I_s	$V_{GS} = 0 \text{ V}$		340	A
I_{SM}	Repetitive; pulse width limited by T_{JM}		1360	A
V_{SD}	$I_F = 100 \text{ A}, V_{GS} = 0 \text{ V}$, Pulse test, $t \leq 300 \mu\text{s}$, duty cycle $d \leq 2 \%$		1.2	V
t_{rr} Q_{RM} I_{RM}	$I_F = 50 \text{ A}, -di/dt = 100 \text{ A}/\mu\text{s}, V_R = 50 \text{ V}$ $T_J = 25^\circ\text{C}$	100 1.4 8	200	ns μC A

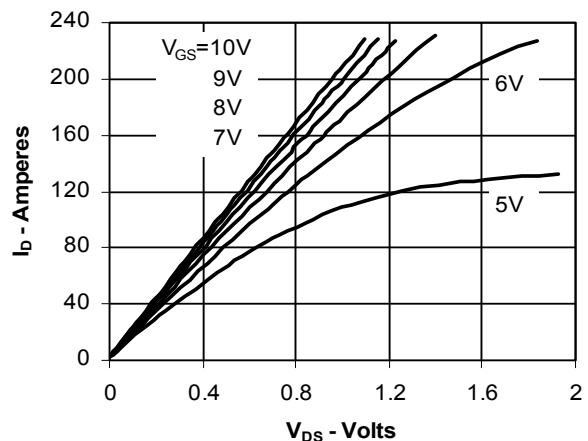
IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by 4,835,592 4,881,106 5,017,508 5,049,961 5,187,117 5,381,025 6,162,665 6,306,728 B1 6,534,343 6,683,344 one or more of the following U.S. patents: 4,850,072 4,931,844 5,034,796 5,063,307 5,237,481 5,486,715 6,259,123 B1 6,404,065 B1 6,583,505 6,710,405 B2

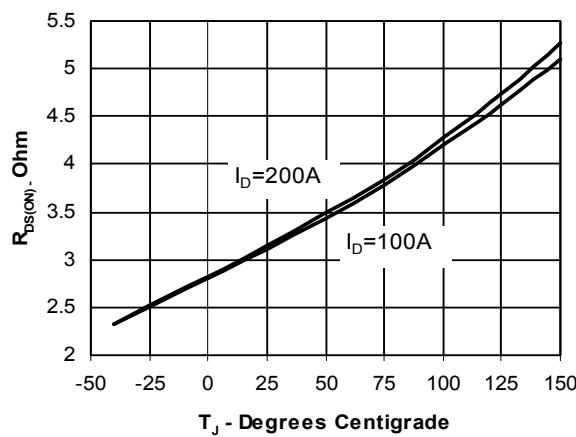
**Fig. 1. Output Characteristics
@ 25 Deg. C**



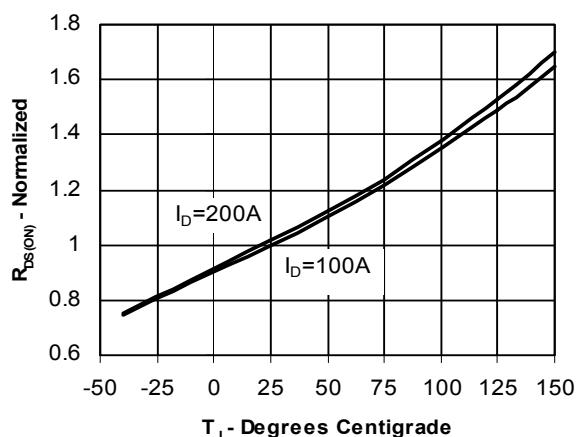
**Fig. 2. Output Characteristics
@ 125 Deg. C**



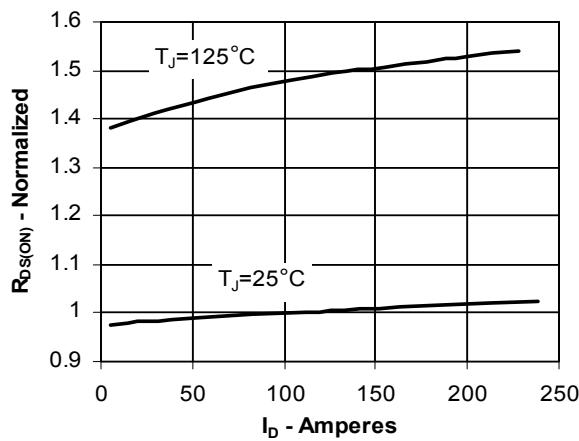
**Fig. 3. Temperature Dependence of
 $R_{DS(ON)}$**



**Fig. 4. $R_{DS(ON)}$ Normalized to $I_{L(RMS)}$
Value vs. Junction Temperature**



**Fig. 5. $R_{DS(ON)}$ Normalized to $I_{L(RMS)}$
Value vs. I_D**



**Fig. 6. Temperature dependence of
Breakdown & Threshold Voltage**

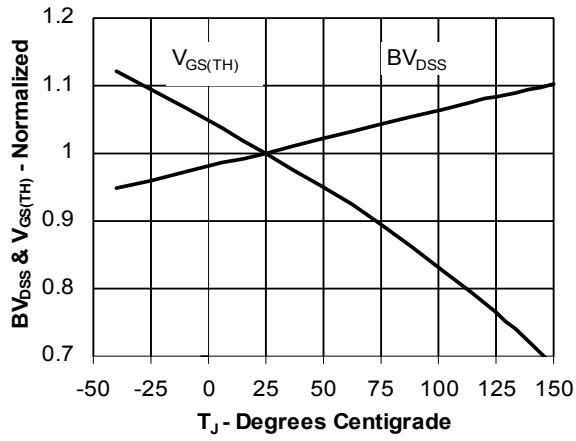


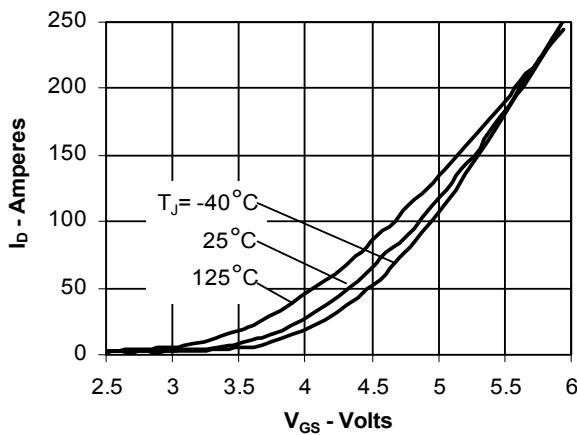
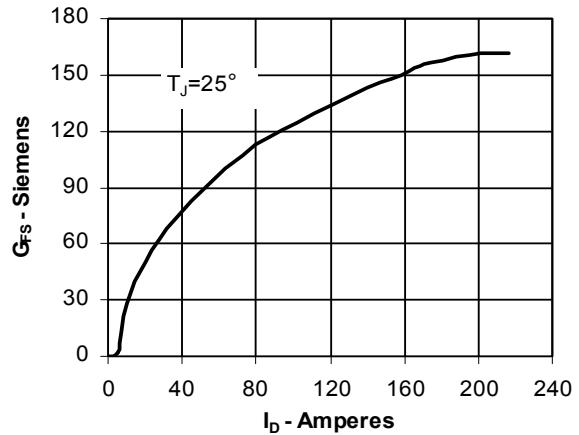
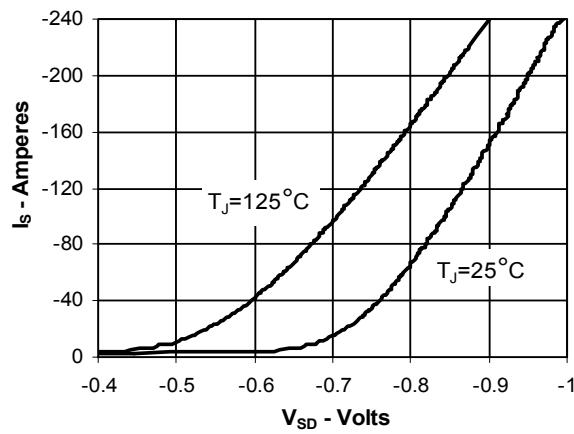
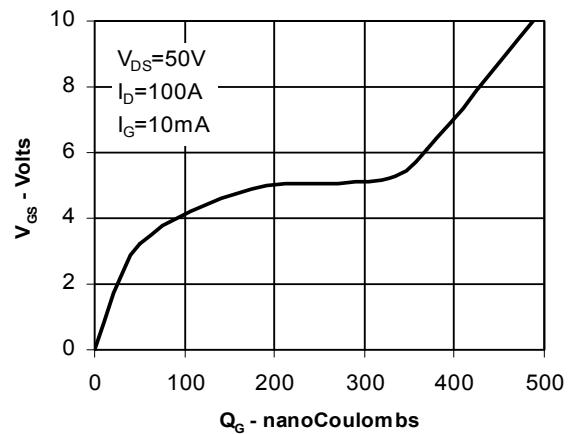
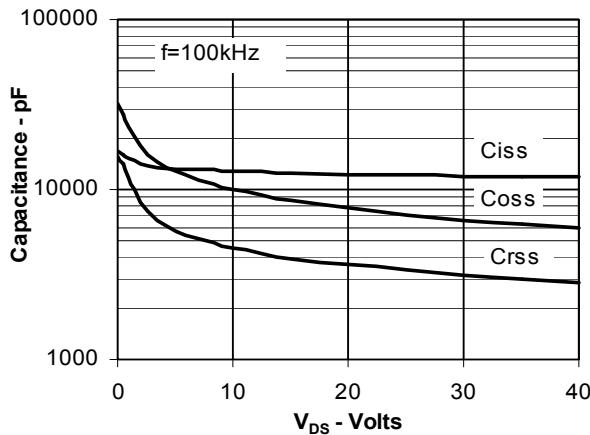
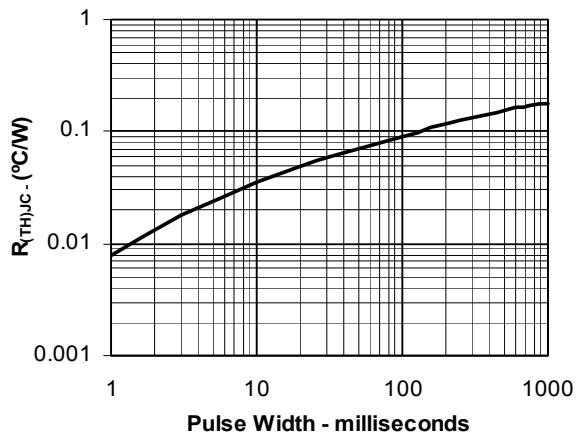
Fig. 7. Input Admittance**Fig. 8. Transconductance****Fig. 9. Source Current vs. Source-To-Drain Voltage****Fig. 10. Gate Charge****Fig. 11. Capacitance****Fig. 12. Transient Thermal Resistance**

Fig. 13. Forward-Bias Safe
Operating Area

